

Module Integration Report on

Brand: Particle

Model: E402D

HW: V1.00

SW: V0.8.0

Module Brand: u-blox

Module Model: SARA-R410M-02B

Module HW: 306A05

Module SW: L0.0.00.00.05.06

SVN: 02

Report Reference: Project NO: 181128C03

Report NO: GC181128C03

Date: January 08, 2019

Test Laboratory:

Bureau Veritas ADT

Hwa Ya Lab & Head Office

No. 19, Hwa Ya 2nd Rd., Wen Hwa Vil, Kwei Shan Dist, Taoyuan, 33383, Taiwan (R.O.C)









This report should not be used by the client to claim product certification, approval, or endorsement by TAF or any government

Note:

This report is for your exclusive use. Any copying or replication of this report to or for any other person or entity, or use of our name or trademark, is permitted only with our prior written permission. This report sets forth our findings solely with respect to the test samples identified herein. The results set forth in this report are not indicative or representative of the quality or characteristics of the lot from which a test sample was taken or any similar or identical product unless specifically and expressly noted. Our report includes all of the tests requested by you and the results thereof based upon the information that you provided to us. You have 60 days from date of issuance of this report to notify us of any material error or omission caused by our negligence, provided, however, that such notice shall be in writing and shall specifically address the issue you wish to raise. A failure to raise such issue within the prescribed time shall constitute your unqualified acceptance of the completeness of this report, the tests conducted and the correctness of the report contents. Unless secflic mention, the uncertainty of measurement has been explicitly taken into account to declare the compliance or non-compliance to the specification

Ext. 1924

**Ext. 1

Phone: 886-3-318-3232 Fax:886-3-211-5834 URL: www.bureauveritas-adt.com



Report NO: GC181128C03

1 Administrative Data

1.1 Project Data

Project Responsible: Han Shih

Date Of Test Report: 2019/01/08

Date of first test: 2018/11/29

Date of last test: 2018/12/14

1.2 Applicant Data

Company Name: Particle Industries,Inc

Street: 126 Post St,4th floor, San Francisco,CA 94108 USA

Contact Person: Zach Supalla

Phone: 415-660-6095

E-Mail: zach@particle.io

1.3 Test Laboratory Data

The following list shows all places and laboratories involved for test result generation:

Bureau Veritas ADT

City:

Country : Contact Person :

Company Name : Bureau Veritas Consumer Products Services (H.K.) Ltd.,

Taoyuan Branch

Mobile Communications Laboratory

Street: No. 19, Hwa Ya 2nd Rd., Wen Hwa Vil,

Kwei Shan Dist., 33383 Taoyuan Taiwan (R.O.C) Mr. Elvis Chen

Phone: 886-3-318-3232 ext. 1918

Fax: 886-3-211-5834

E Mail: elvis.chen@tw.bureauveritas.com

Laboratory Details

Lab ID	Identification	Responsible	Accreditation Info	
Lab 1	TP001 - IOP Environment	Eric SW Chiu	TAF Accreditation No.: 2770	
Lab 2	TP092 - Protocol - R&S CMW500	Peace Lin	TAF Accreditation No.: 2770	
Lab 3	TP118 - COMPRION UT3 Platform	Cara Huang	TAF Accreditation No.: 2770	

1.4 Signature of the Testing Responsible

Mala Sk

Nilson She

responsible for tests performed in: Lab 1, Lab 2, Lab 3



Report NO: GC181128C03

2 Test Object Data

2.1 General OUT Description

The following section lists all OUTs (Object's Under Test) involved during testing.

OUT: E402D

Type / Model / Family: Brand: Particle

Model: E402D HW: V1.00 SW: V0.8.0

Module Brand: u-blox

Module Model: SARA-R410M-02B

Module HW: 306A05

Module SW: L0.0.00.00.05.06

Manufacturer:

Company Name: Particle Industries,Inc

Street: 126 Post St,4th floor, San Francisco,CA 94108 USA

Contact Person: Frank Yang
Phone: 13590495425
E-Mail: frank@particle.io

2.2 Detailed Description of OUT Samples

Sample: EUT 01

OUT Identifier E402D

Sample Description

HW Status 306A05

SW Status L0.0.00.00.05.06

Low Voltage 3.6 V Low Temp. -10 °C High Voltage 4.4 V High Temp. 55 °C Nominal Voltage 4.1 V Normal Temp. 25 °C

Parameter List:

Parameter Description Value

Parameter for Scope LTE_v1

 IMEISV
 3527530902046802

 Official IMEI
 352753090204684

Parameter for Scope UTRA_v2

Official IMEI 352753090204684



Report NO: GC181128C03

2.3 **OUT Features**

Features for OUT: E402D

> Designation Description Allowed Values Supported Value(s) Features for scope: LTE_v1 36521_A.4. E-UTRA FDD 1-1/1 36521_A.4. Frequency band: 1850-1910, 1930-1990 MHz 3-3/2 36521_A.4. Frequency band: 1710-1785, 1805-1880 MHz 3-3/3 36521_A.4. Frequency band: 1710-1755, 2110-2155 MHz 3-3/4 36521_A.4. Frequency band: 824-849, 869-894 MHz 3-3/5 36521 A.4. Frequency band: 698-716, 729-746 MHz 3-3/12 36521_A.4. Frequency band: 777-787, 746-756 MHz 3-3/13 36521_A.4. Frequency band: 703-748, 758-803 MHz 3-3/28 36523 A.4. E-UTRA FDD 1-1/1 Frequency band: 1710-1755, 2110-2155 MHz 36523 A.4. 3.1-1/4 recommended - the test case is recommended Features for scope: UTRA_v2 102230_A. Class B

1/4

102230_A. Class C

1/5 R recommended - the test case is recommended

2.4 **Setups used for Testing**

For each setup a relation is given to determine if and which samples and auxiliary equipment is used. The left side list all OUT samples and the right side lists all auxiliary equipment for the given setup.

Setup No. List of OUT samples List of auxiliary equipment Sample No. Sample Description AE No. AE Description

01.01.01 (HW: 306A05 SW: L0.0.00.00.05.06)

Sample: EUT 01



Report NO: GC181128C03

3 Results

3.1 General

Documentation of tested devices:

Available at the test laboratory.

Interpretation of the

test results:

The results of the inspection are described on the following pages, where 'Conformity' or 'Passed' means that the certification criteria were verified and that the tested device is

conform to the applied standard.

In cases where 'Declaration' is printed, the required documents are available in the manufacturers product documentation.

In cases where 'not applicable' is printed, the test case requirements are not relevant to the specific equipment

implementation.

Note: 1.Uncertainty for each test case and measurement were

calculated implemented according to test equipment uncertainty

document.

2.Test condition not required due to no practical connection made to the power supply, and then normal condition performed with standard battery. The standard battery would be measured prior to testing, and make sure the battery voltage was at full

charge condition.

3.2 List of the Applicable Body

(Body for Scope: LTE_v1)

Designation Description

NAPRD.03 v5.34 bis Official PTCRB NAPRD.03 v5.34

(Body for Scope: UTRA_v2)

Designation Description

NAPRD.03 v5.34 bis Official PTCRB NAPRD.03 v5.34



Report NO: GC181128C03

3.3 List of Test Specification

Test Specification: 3GPP TS 36.124

Date / Version 2018/04/05 Version: V15.2.0

Title: Technical Specification

3rd Generation Partnership Project;

Technical Specification Group Radio Access Network; Evolved Universal Terrestrial Radio Access (E-UTRA); ElectroMagnetic Compatibility (EMC) requirements for mobile terminals and ancillary eequipment

(Release 15)

Test Specification: 3GPP TS 36.523-1

Date / Version 2018/06/26 Version: V15.2.0

Title: 3rd Generation Partnership Project;

Technical Specification Group Radio Access Network; Evolved Universal Terrestrial Radio Access (E-UTRA)

and Evolved Packet Core (EPC);

User Equipment (UE) conformance specification; Part 1: Protocol conformance specification

(Release 15)

Test Specification: ETSI TS 102 230-1

Date / Version 2016/06/01 Version: V11.0.0

Title: Smart Cards;

UICC-Terminal interface;

Physical, electrical and logical test specification; Part 1: Terminal features (Release 11)



Report NO: GC181128C03

Test Equipment Details

4.1 **List of Used Test Equipment**

The calibration, hardware and software states are shown for the testing period.

Test Equipment CMW500

Lab ID: Lab 2

ROHDE & SCHWARZ GmbH & Co.KG Manufacturer:

Description: CMW500 Type: CMW500

Single Devices for CMW500

Single Device Name	Туре	Serial Number	Manufacturer	
CMW CONTROLLER	CMWC	101407	R&S	
RF COMBINER	CMW-Z24	101815	R&S	
Wideband Radio communication tester	CMW500	159168	R&S	
	Calibration Details		Last Execution	Next Exec.
	Calibration		2018/10/25	2019/10/25
Wideband Radio communication tester	CMW500	159169	R&S	
	Calibration Details		Last Execution	Next Exec.
	Calibration		2018/10/24	2019/10/24

Test Equipment RSE Test System 1

Lab ID: Lab 1

Bureau Veritas ADT Manufacturer: Description: RSE Test System 1 RSE Test System Type:

Serial Number:

Single Devices for RSE Test System 1

Single Device Name	Туре	Serial Number	Manufacturer	
18GHz ~ 40GHz Amplifier	EMC 184045	980116		
ADT_Radiated_V7.6.1 5.9.3	ADT_Radiated	n/a	Bureau Veritas ADT	
	HW/SW Status		Date of Start	Date of End
	SW: V7.6.15.9.3		2010/02/01	-
Antenna Tower	MA 4000	MA 4000/012/615030 3/L	Inn-co GmbH	
BILOG Antenna	VULB 9168	9168-158	SCHWARZBECK	
	Calibration Details		Last Execution	Next Exec.
	Calibration		2017/12/11	2018/12/11
Controller	SI-300	130009	TDK RF.	
HORN Antenna	3117	00034126	ETS	
	Calibration Details		Last Execution	Next Exec.
	Calibration		2017/11/30	2018/11/30
HORN Antenna	BBHA 9170	BBHA9170243	SCHWARZBECK	
	Calibration Details		Last Execution	Next Exec.
	Calibration		2017/12/14	2018/12/14



Report NO: GC181128C03

Single Devices for RSE Test System 1 (continued)

Single Device Name	Туре	Serial Number	Manufacturer	
Preamplifier	8447D	2944A10738	Agilent Technologies	
	Calibration Details		Last Execution	Next Exec.
	Calibration		2018/08/21	2019/08/21
Preamplifier	8449B	3008A01963	Agilent Technologi	Next Exec. 2019/08/21 gies Next Exec. 2019/08/21
	Calibration Details		Agilent Technologies Last Execution Next Ex 2018/08/21 2019/08, Agilent Technologies Last Execution Next Ex 2018/08/21 2019/08, Agilent Technologies Last Execution Next Ex 2018/09/10 2019/09, Mini-Circuits Last Execution Next Ex	Next Exec.
	Calibration		2018/08/21	2019/08/21
Spectrum Analyzer	E4446A	MY51100039	Agilent Technologies	
	Calibration Details		Last Execution	Next Exec.
	Calibration		2018/09/10	2019/09/10
Splitters/Combiners	ZN2PD-9G		Mini-Circuits	
	Calibration Details		Last Execution	Next Exec.
	Calibration		2018/06/21	2020/06/21
Turn Table		SN40303		

Test Equipment UT3

Lab ID:Lab 3Manufacturer:COMPRION

Description: COMPRION UT3 Platform

Type: UT3

Serial Number: 40070-45013

Single Devices for UT3

Single Device Name	Туре	Serial Number	Manufacturer	
UT3 Analog Probe	APR-TT	45013	COMPRION	
	Calibration Details		Last Execution	Next Exec.
	Calibration		2018/06/13	2019/06/13
	HW/SW Status		Date of Start	Date of End
	HW: 3.0		2016/11/16	
UT3 APR	UT3 APR	40070	COMPRION	
	HW/SW Status		Date of Start	Date of End
	HW: 3.0		2017/10/20	

HCI Monitoring: 1.6 SWP Monitoring: 1.8

Device Test Center: R 7.4.6473.20589



Report NO: GC181128C03

5 Annex

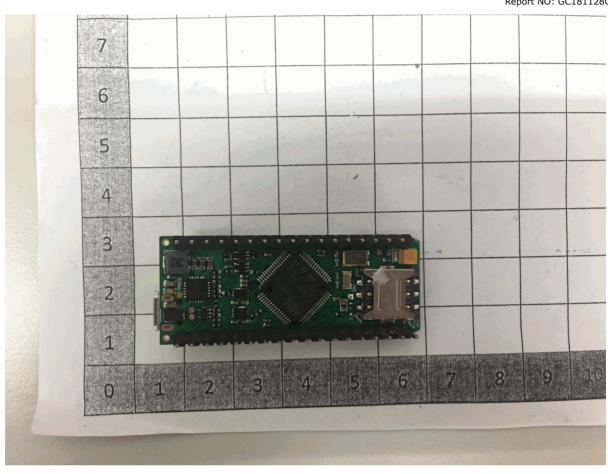
5.1 Additional Information for Sample Description



Photographs for the EUT 1.Front View of the EUT



Reference: Project NO: 181128C03 Report NO: GC181128C03



Photographs for the EUT 2.Rear View of the EUT

5.2 Additional Information for TestResult

Test Case	Description	Test_Spec	Category	Band	Verdict	Sample	TP
5.1.1	Phase preceding Terminal power on	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
5.1.2.2	Phase during UICC power on: 1,8 V - 3 V	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
5.1.3.2	Phase during Terminal power off: 1,8 V - 3 V	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
5.1.5.3	Reaction of 1,8 V technology Terminals on type recognition of 1,8 V technology UICCs	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
5.1.5.4	Reaction of 1,8 V technology Terminals on type recognition of 3V technology UICCs	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
5.1.5.6	Reaction of a Terminals receiving no ATR	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
5.2.2.3	Electrical tests on contact C1, Test 1: 1,8 V - 3 V	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
5.2.2.4	Electrical tests on contact C1, Test 2: 1,8 V - 3 V	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
5.2.3.2	Electrical tests on contact C2: 1,8 V - 3 V	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
5.2.4.2	Electrical tests on contact C3: 1,8 V - 3 V	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
5.2.5.3	Electrical tests on contact C7, Test 1: 1,8 V - 3 V	ETSI TS 102 230	Α	Single	Passed	01.01.01	118
8.2; Frequency Band = FDD2	Radiated spurious emissions, MS allocated a channel	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD2	Radiated spurious emissions, MS in idle mode	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD3	Radiated spurious emissions, MS allocated a channel	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD3	Radiated spurious emissions, MS in idle mode	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD4	Radiated spurious emissions, MS allocated a channel	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD4	Radiated spurious emissions, MS in idle mode	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD5	Radiated spurious emissions, MS allocated a channel	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD5	Radiated spurious emissions, MS in idle mode	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD12	Radiated spurious emissions, MS allocated a channel	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD12	Radiated spurious emissions, MS in idle mode	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD13	Radiated spurious emissions, MS allocated a channel	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD13	Radiated spurious emissions, MS in idle mode	36.124	Α	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD28	Radiated spurious emissions, MS allocated a channel	36.124	A	Single	Passed	01.01.01	1
8.2; Frequency Band = FDD28	Radiated spurious emissions, MS in idle mode	36.124	Α	Single	Passed	01.01.01	1
9.1.4.2; Frequency Band = FDD4	Identification procedure / IMEI / IMEISV requested	36.523-1	А	Single	Passed	01.01.01	92



Reference: Project NO: 181128C03 Report NO: GC181128C03

6 Index

1 Ad	dministrative Data	2
1.1	Project Data	2
1.2	Applicant Data	2
1.3	Test Laboratory Data	2
	Signature of the Testing Responsible	2
	est Object Data	3
2.1	General OUT Description	3
2.2	Detailed Description of OUT Samples	3
2.3	OUT Features	4
2.4	Setups used for Testing	4
	esults	5
3.1	General	5
3.2	List of the Applicable Body	5
3.3	List of Test Specification	6
4 Te	est Equipment Details	7
4.1	List of Used Test Equipment	7
5 An		9
5.1	Additional Information for Sample Description	
5.2	Additional Information for TestResult	
6 In	dex	11